

BRITISH STANDARD 9321 : 1971

UDC 621.382.2/.3

**DECLARED
OBSOLESCE
MAR 1994**

RULES

FOR THE PREPARATION OF
DETAIL SPECIFICATIONS
FOR SEMICONDUCTOR DEVICES
OF ASSESSED QUALITY
MICROWAVE MIXER DIODES
(PULSE OPERATION)

Confirmed

SEP 1988

AMD 1976

AMENDMENT SLIP No. 1 published June 1976 to BS 9321 : 1971.

RULES FOR THE PREPARATION OF
DETAIL SPECIFICATIONS FOR SEMICONDUCTOR
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Revised text

Page 3. Scope

Add at the end "The incorporation of any item identified as 'where appropriate' is at the specification writers discretion but where this is given against an inspection requirement the test may not be specified at a lower inspection level or group."

Page 4. Clause 4. Characteristics

After the first line, insert new paragraph as follows:

"Unless otherwise specified, characteristics are given under d.c. conditions. However, when a pulse method of measurement is specified in the inspection requirements, either the words 'under pulse conditions' or the appropriate test conditions shall be stated against the corresponding characteristic."

Page 6. Clause 6. Supplementary information

Replace the first line by the following:

"Manufacturers are strongly recommended to include either the supplementary information given below as minimum design data or else to give a reference to the commercial data."